


<b>Search Notes</b>  	<b>Application/Control No.</b>  10826476	<b>Applicant(s)/Patent Under Reexamination</b>  KIHARA ET AL.
	<b>Examiner</b>  Bibbee, Jared M	<b>Art Unit</b>  2161

<b>SEARCHED</b>
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Class	Subclass	Date	Examiner
707	3, 10, 101, 102 (U.S. PATENTS+) P.G. PUBS	5/24/07	SL

<b>SEARCH NOTES</b>
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Search Notes	Date	Examiner
Updated search within EAST	5/23/2007	JMB
Consulted with Primary Examiner with respect to allowing	5/23/2007	JMB

<b>INTERFERENCE SEARCH</b>
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Class	Subclass	Date	Examiner
707	101, 102	5/23/2007	JMB
709	223	5/23/2007	JMB